## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10697108	BEISEL ET AL.	
Examiner	Art Unit	
Lee, Siu M	2611	

SEARCHED					
Class	Subclass	Date	Examiner		
375	224, 316	2/17/2007	Siu M. Lee		
398	1-8	2/17/2007	Siu M. Lee		
370	217-229	2/17/2007	Siu M. Lee		

SEARCH NOTES					
Search Notes	Date	Examiner			
EAST	2/17/2007	Siu M. Lee			
Discuss the application with Cheih Fan	2/17/2007	Siu M. Lee			

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		